

Notice of References Cited	Application/Control No. 10/733,313	Applicant(s)/Patent Under Reexamination CHANG, WEI-HOU	
	Examiner David E. Graybill	Art Unit 2822	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,683,469	08-1972	Capek et al.	29/25.42
	B	US-4,312,023	01-1982	Frappart et al.	361/243
	C	US-6,373,684	04-2002	Tanida et al.	361/305
	D	US-2001/0048580	12-2001	Tanida et al.	361/303
	E	US-5,839,363	11-1998	Yanagisawa et al.	101/123
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11074145 A	03-1999	Japan	KURIHARA et al.	H01G 04/12
	O	JP 11102423 A	04-1999	Japan		B42D 15/10
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.